

FFATURES

SCES145C-OCTOBER 1998-REVISED JUNE 2005

FF	ATURES		GG PA	CKN	26
٠	Member of the Texas Instruments Widebus+™	U	(TOP V	-	
	Family				
•	UBT™ Transceiver Combines D-Type Latches	1CLKENAB			1 CLKENBA
	and D-Type Flip-Flops for Operation in	LEAB [LEBA
	Transparent, Latched, or Clocked Modes				
٠	Operates From 1.65 V to 3.6 V	1ERRA			1ERRB
•	Inputs Accept Voltages to 5.5 V	1APAR [GND]] 1BPAR] GND
٠	Max t _{pd} of 5.4 ns at 3.3 V	1A1 [] 1B1
•	Typical V _{OLP} (Output Ground Bounce) < 0.8 V	1A2 [] 1B2
	at $V_{CC} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$	1A3 [56] 1B3
•	Typical V _{OHV} (Output V _{OH} Undershoot) > 2 V at	V _{CC}		55] V _{CC}
	V _{CC} = 3.3 V, T _A = 25°C	1A4] 1B4
•	Simultaneously Generates and Checks Parity	1A5 [] 1B5
•	Option to Select Generate Parity and Check or	1A6 [] 1B6
	Feedthrough Data/Parity in A-to-B or B-to-A	GND [] GND
	Direction	1A7 [] 1B7
٠	Supports Mixed-Mode Signal Operation on All	1A8 [2A1 [] 1B8] 2B1
	Ports (5-V Input/Output Voltage With	2A1 [2A2 [] 2B2
	3.3-V V _{CC})		19		GND
٠	I _{off} Supports Partial-Power-Down Mode	2A3 [] 2B3
	Operation	2A4 [] 2B4
•	Bus Hold on Data Inputs Eliminates the Need	2A5 [22	43] 2B5
	for External Pullup/Pulldown Resistors	V _{CC} [23	42] V _{CC}
•	Latch-Up Performance Exceeds 100 mA Per	2A6 [] 2B6
	JESD 78, Class I	2A7 [2B7
٠	ESD Protection Exceeds JESD 22	2A8 [] 2B8
	– 2000-V Human-Body Model (A114-A)	GND [] GND
	– 200-V Machine Model (A115-A)	2APAR [2ERRA [2BPAR
		OEAB] 2ERRB] OEBA
		SEL			ODD/EVEN
		2 <u>CLKENAB</u>			2CLKENBA
			<u> </u>	55	

DESCRIPTION/ORDERING INFORMATION

This 18-bit (dual-octal) noninverting registered transceiver is designed for 1.65-V to 3.6-V V_{CC} operation.

The SN74LVCH16901 is a dual 9-bit to dual 9-bit parity transceiver with registers. The device can operate as a feed-through transceiver, or it can generate/check parity from the two 8-bit data buses in either direction.

ORDERING INFORMATION

T _A	T _A PACKAGE ⁽¹⁾		ORDERABLE PART NUMBER	TOP-SIDE MARKING	
–40°C to 85°C	TSSOP – DGG	Tape and reel	SN74LVCH16901DGGR	LVCH16901	

Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at (1) www.ti.com/sc/package.



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SCES145C-OCTOBER 1998-REVISED JUNE 2005

DESCRIPTION/ORDERING INFORMATION (CONTINUED)

The SN74LVCH16901 features independent clock (CLKAB or CLKBA), latch-enable (LEAB or LEBA), and dual 9-bit clock-enable (CLKENAB or CLKENBA) inputs. It also provides parity-enable (SEL) and parity-select (ODD/EVEN) inputs and separate error-signal (ERRA or ERRB) outputs for checking parity. The direction of data flow is controlled by output-enable (OEAB and OEBA) inputs. When SEL is low, the parity functions are enabled. When SEL is high, the parity functions are disabled, and the device acts as an 18-bit registered transceiver.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry holds unused or undriven inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

This device is fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

	I	INPUTS			OUTPUT
CLKENAB	OEAB	LEAB	CLKAB	Α	В
Х	Н	Х	Х	Х	Z
х	L	Н	Х	L	L
х	L	Н	Х	Н	Н
н	L	L	Х	Х	B ₀ ⁽²⁾
L	L	L	\uparrow	L	L
L	L	L	\uparrow	н	Н
L	L	L	L	Х	B ₀ ⁽²⁾
L	L	L	Н	Х	B ₀ ⁽²⁾ B ₀ ⁽³⁾

FUNCTION TABLES

FUNCTION⁽¹⁾

(1) A-to-B data flow is shown: B-to-A flow is similar, but uses OEBA, LEBA, and CLKENBA.

(2) Output level before the indicated steady-state input conditions were established

(3) Output level before the indicated steady-state input conditions were established, provided that CLKAB was low before LEAB went low

PARITY ENABLE

	INPUTS			OPERATION OR FUNCTION				
SEL	OEBA	OEAB	OF ERATION OR FUNCTION					
L	Н	L	Parity is checked on port A and is generated on port B.					
L	L	Н	Parity is checked on port B and is generated on port A.					
L	Н	н	Parity is checked on port B and port A.					
L	L	L	Parity is generated on port A and B if device is in FF mode.					
Н	L	L		Q _A data to B, Q _B data to A				
н	L	н	Parity functions are disabled; device	Q _B data to A				
н	Н	L	acts as a standard 18-bit registered transceiver.	Q _A data to B				
Н	Н	Н	Isolation					

SCES145C-OCTOBER 1998-REVISED JUNE 2005

FUNCTION TABLES (CONTINUED)

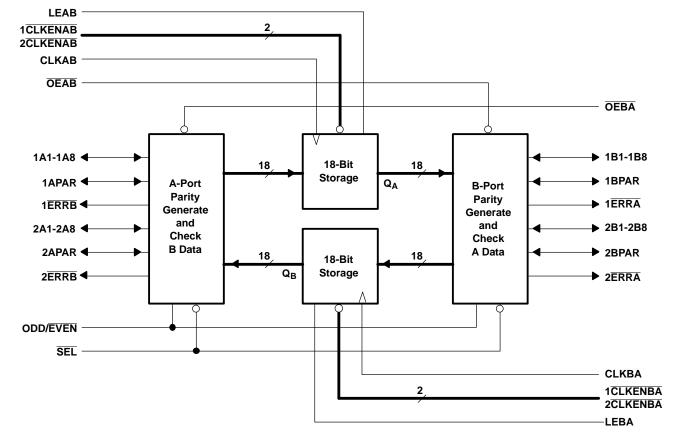
					I ANIT I						
				INPUTS					OUT	PUTS	
SEL	OEBA	OEAB	ODD/EVEN	$\Sigma \text{ OF INPUTS}$ A1–A8 = H	Σ OF INPUTS B1–B8 = H	APAR	BPAR	APAR	ERRA	BPAR	ERRB
L	Н	L	L	0, 2, 4, 6, 8	N/A	L	N/A	N/A	Н	L	Z
L	Н	L	L	1, 3, 5, 7	N/A	L	N/A	N/A	L	Н	Z
L	Н	L	L	0, 2, 4, 6, 8	N/A	н	N/A	N/A	L	L	Z
L	Н	L	L	1, 3, 5, 7	N/A	Н	N/A	N/A	Н	Н	Z
L	L	Н	L	N/A	0, 2, 4, 6, 8	N/A	L	L	Z	N/A	Н
L	L	н	L	N/A	1, 3, 5, 7	N/A	L	н	Z	N/A	L
L	L	н	L	N/A	0, 2, 4, 6, 8	N/A	Н	L	Z	N/A	L
L	L	н	L	N/A	1, 3, 5, 7	N/A	н	н	Z	N/A	н
L	Н	L	Н	0, 2, 4, 6, 8	N/A	L	N/A	N/A	L	Н	Z
L	н	L	н	1, 3, 5, 7	N/A	L	N/A	N/A	н	L	Z
L	н	L	н	0, 2, 4, 6, 8	N/A	н	N/A	N/A	н	н	Z
L	н	L	н	1, 3, 5, 7	N/A	н	N/A	N/A	L	L	Z
L	L	Н	Н	N/A	0, 2, 4, 6, 8	N/A	L	н	Z	N/A	L
L	L	н	н	N/A	1, 3, 5, 7	N/A	L	L	Z	N/A	н
L	L	н	н	N/A	0, 2, 4, 6, 8	N/A	н	н	Z	N/A	н
L	L	н	н	N/A	1, 3, 5, 7	N/A	н	L	Z	N/A	L
L	Н	Н	L	0, 2, 4, 6, 8	0, 2, 4, 6, 8	L	L	Z	Н	Z	Н
L	н	н	L	1, 3, 5, 7	1, 3, 5, 7	L	L	Z	L	Z	L
L	н	н	L	0, 2, 4, 6, 8	0, 2, 4, 6, 8	н	н	Z	L	Z	L
L	н	н	L	1, 3, 5, 7	1, 3, 5, 7	н	н	Z	н	Z	н
L	Н	Н	Н	0, 2, 4, 6, 8	0, 2, 4, 6, 8	L	L	Z	L	Z	L
L	н	Н	н	1, 3, 5, 7	1, 3, 5, 7	L	L	Z	н	Z	н
L	н	Н	Н	0, 2, 4, 6, 8	0, 2, 4, 6, 8	н	н	Z	н	Z	н
L	н	Н	Н	1, 3, 5, 7	1, 3, 5, 7	н	н	Z	L	Z	L
L	L	L	L	N/A	N/A	N/A	N/A	PE ⁽¹⁾	Z	PE ⁽¹⁾	Z
L	L	L	н	N/A	N/A	N/A	N/A	PO ⁽²⁾	Z	PO ⁽²⁾	z

PARITY

(1) Parity output is set to the level so that the specific bus side is set to even parity.

Parity output is set to the level so that the specific bus side is set to odd parity. (2)

SCES145C-OCTOBER 1998-REVISED JUNE 2005



FUNCTIONAL BLOCK DIAGRAM

Texas ISTRUMENTS

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Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	6.5	V
VI	Input voltage range ⁽²⁾	Input voltage range ⁽²⁾			V
Vo	Voltage range applied to any output in the	e high-impedance or power-off state ⁽²⁾	-0.5	6.5	V
Vo	Voltage range applied to any output in the	e high or low state ⁽²⁾⁽³⁾	-0.5	V _{CC} + 0.5	V
I _{IK}	Input clamp current	V ₁ < 0		-50	mA
I _{OK}	Output clamp current	V _O < 0		-50	mA
I _O	Continuous output current			±50	mA
	Continuous current through each V_{CC} or (GND		±100	mA
θ_{JA}	Package thermal impedance ⁽⁴⁾			55	°C/W
T _{stg}	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The value of V_{CC} is provided in the recommended operating conditions table.

(4) The package thermal impedance is calculated in accordance with JESD 51-7.

SCES145C-OCTOBER 1998-REVISED JUNE 2005

Recommended Operating Conditions⁽¹⁾

			MIN	MAX	UNIT	
V	Cupply voltage	Operating	1.65	3.6	V	
V _{CC}	Supply voltage	Data retention only	1.5		v	
		V _{CC} = 1.65 V to 1.95 V	$0.65 \times V_{CC}$			
V _{IH}	High-level input voltage	V_{CC} = 2.3 V to 2.7 V	1.7		V	
		$V_{CC} = 2.7 V \text{ to } 3.6 V$	2			
		V _{CC} = 1.65 V to 1.95 V		$0.35 \times V_{CC}$		
VIL	Low-level input voltage	V_{CC} = 2.3 V to 2.7 V		0.7	V	
		$V_{CC} = 2.7 V \text{ to } 3.6 V$		0.8		
VI	Input voltage		0	5.5	V	
V	Output voltage	High or low state	0	V _{CC}	V	
Vo	Oulput voltage	3-state	0	5.5	v	
		V _{CC} = 1.65 V		-4		
	High lovel output ourrent	$V_{CC} = 2.3 V$		-8	mA	
IOH	High-level output current	$V_{CC} = 2.7 V$		-12	ША	
		$V_{CC} = 3 V$		-24		
		V _{CC} = 1.65 V		4		
	Low level output ourrept	$V_{CC} = 2.3 V$		8	mA	
I _{OL}	Low-level output current	$V_{CC} = 2.7 V$		12	ШA	
		$V_{CC} = 3 V$		24		
$\Delta t / \Delta v$	Input transition rise or fall rate			5	ns/V	
T _A	Operating free-air temperature		-40	85	°C	

(1) All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

SCES145C-OCTOBER 1998-REVISED JUNE 2005

Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PA	RAMETER	TEST CO	NDITIONS	V _{cc}	MIN	TYP ⁽¹⁾ MAX	UNIT		
		I _{OH} = -100 μA		1.65 V to 3.6 V	V _{CC} – 0.2				
		$I_{OH} = -4 \text{ mA}$		1.65 V	1.2				
		I _{OH} = -8 mA		2.3 V	1.7		v		
V _{OH}		1 10 mA		2.7 V	2.2		V		
		I _{OH} = -12 mA		3 V	2.4				
		I _{OH} = -24 mA		3 V	2.2				
		I _{OL} = 100 μA		1.65 V to 3.6 V		0.2			
		$I_{OL} = 4 \text{ mA}$		1.65 V		0.45			
V _{OL}		I _{OL} = 8 mA		2.3 V		0.7	V		
		I _{OL} = 12 mA		2.7 V		0.4			
		I _{OL} = 24 mA		3 V		0.55			
I _I	Control inputs	$V_{I} = 0$ to 5.5 V		3.6 V		±5	μA		
		$V_{I} = 0.58 V$ $V_{I} = 1.07 V$ $V_{I} = 0.7 V$ $V_{I} = 1.7 V$			25				
				1.65 V	-25				
				221/	45		μA		
I _{I(hold)}	A or B ports			2.3 V	-45				
		V _I = 0.8 V		2.14	75				
		V ₁ = 2 V		3 V	-75				
		V _I = 0 to 3.6 V ⁽²⁾		3.6 V		±600			
I _{off}		$V_1 \text{ or } V_0 = 5.5 \text{ V}$		0		±10	μA		
I _{OZ} ⁽³⁾		$V_0 = 0 \text{ to } 5.5 \text{ V}$		3.6 V		±10	μA		
		$V_I = V_{CC}$ or GND	- I _O = 0	3.6 V		20	μA		
сс		$3.6 \ V \le V_I \le 5.5 \ V^{(4)}$	1 ₀ = 0	5.0 V		20	μΑ		
ΔI_{CC}		One input at $V_{CC} - 0.6 V$,	Other inputs at $V_{\mbox{\scriptsize CC}}$ or $\mbox{\scriptsize GND}$	2.7 V to 3.6 V		500	μA		
C _i	Control inputs	$V_{I} = V_{CC}$ or GND		3.3 V		7	pF		
C _{io}	A or B ports	s $V_0 = V_{CC}$ or GND		3.3 V		9.5	pF		

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TEXAS INSTRUMENTS

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(1) All typical values are at $V_{CC} = 3.3 \text{ V}$, $T_A = 25^{\circ}\text{C}$. (2) This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.

SCES145C-OCTOBER 1998-REVISED JUNE 2005

Timing Requirements

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

			V _{CC} = 1	.8 V ⁽¹⁾	V _{CC} = ± 0.	2.5 V 2 V	V _{CC} =	2.7 V	V _{CC} = 3 ± 0.3	3.3 V 3 V	UNIT	
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
f _{clock}	Clock frequency			125		125		125		125	MHz	
t _w	Dulas duration	CLK↑	4		3		3		3			
	Pulse duration	LE high	3		3		3		3		ns	
		A, APAR or B, BPAR before CLK [↑]	4.7		2.7		2.8		2.5			
t _{su}	Setup time	CLKEN before CLK [↑]	4.5		2.9		2.9		2.5		ns	
		A, APAR or B, BPAR before LE \downarrow	0		2.2		2.1		2			
		A, APAR or B, BPAR after CLK↑	0		1.2		1.2		1.3		ns	
t _h	Hold time	CLKEN after CLK [↑]	0		1.3		1.3		1.5			
		A, APAR or B, BPAR after LE \downarrow	1		1.7		1.9		1.7			

(1) Texas Instruments SPICE simulation data

Switching Characteristics

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO (OUTPUT)	V _{CC} = 1	.8 V ⁽¹⁾	V _{CC} = ± 0.2	2.5 V 2 V	V _{CC} =	2.7 V	V _{CC} = ± 0.3	3.3 V 3 V	UNIT
	(INPUT)	(001201)	MIN	TYP	MIN	MAX	MIN	MAX	MIN	MAX	
f _{max}			125		125		125		125		MHz
	A or B	B or A		5.9	1	6.2		5.8	1	5.4	
	AUD	BPAR or APAR		12.7	2	9.9		8.6	2	7.7	
	APAR or BPAR	BPAR or APAR		7	1	6.7		6.2	1	5.7	
	AFAR UI DFAR	ERRA or ERRB		13	2	10.7		9.7	2	8.5	
-	ODD/EVEN	ERRA or ERRB		9.9	1.5	9.7		8.9	1.5	7.8	
		BPAR or APAR		10.4	1.5	9.3		8.6	1.5	7.5	
-	SEL	BPAR or APAR		6.9	1	7.1		6.9	1	6.1	
-	CLKAB or CLKBA	A or B		6.9	1	7.4		6.8	1	6.1	
t _{pd}		BPAR or APAR parity feedthrough		8.5	1.5	8.1		7.3	1.5	6.6	ns
		BPAR or APAR parity generated		14.1	2.5	11.2		9.7	2	8.7	
		ERRA or ERRB		14.3	2.5	11.5		9.9	2	8.9	
-		A or B		6.8	1	7		6.5	1	5.8	
	LEAB or LEBA	BPAR or APAR parity feedthrough		7.9	1.5	7.7		7	1.5	6.3	
	LEAD OF LEDA	BPAR or APAR parity generated		13.6	2.5	10.8		9.3	2	8.4	
		ERRA or ERRB		13.5	2.5	10.9		9.5	2	8.5	
t _{en}	OEAB or OEBA	B, BPAR or A, APAR		6.8	1.4	7.3		7.1	1	6.3	ns
t _{dis}	OEAB or OEBA	B, BPAR or A, APAR		6.9	1.3	7.1		6.2	1.5	5.9	ns
t _{en}	OEAB or OEBA	ERRA or ERRB		7.4	1.4	7.2		6.5	1	5.9	ns
t _{dis}	OEAB or OEBA	ERRA or ERRB		9.3	1.3	8.3		7.5	1	6.7	ns
t _{en}	SEL	ERRA or ERRB		7.6	1.4	7.7		7.5	1	6.5	ns
t _{dis}	SEL	ERRA or ERRB		7.8	1.3	7.4		6.4	1.5	5.9	ns

(1) Texas Instruments SPICE simulation data

SCES145C-OCTOBER 1998-REVISED JUNE 2005

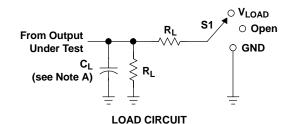
Operating Characteristics

 $T_A = 25^{\circ}C$

	PARAMETER		TEST CONDITIONS	V _{CC} = 1.8 V TYP	V _{CC} = 2.5 V TYP	V _{CC} = 3.3 V TYP	UNIT	
C	Power dissipation capacitance	Outputs enabled	f = 10 MHz	37	52	68	~F	
C _{pd}	per transceiver	Outputs disabled		16	22	28	рг	

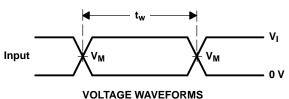
SCES145C-OCTOBER 1998-REVISED JUNE 2005

PARAMETER MEASUREMENT INFORMATION

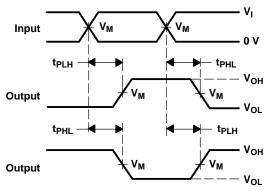


TEST	S1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	V _{LOAD}
t _{PHZ} /t _{PZH}	GND

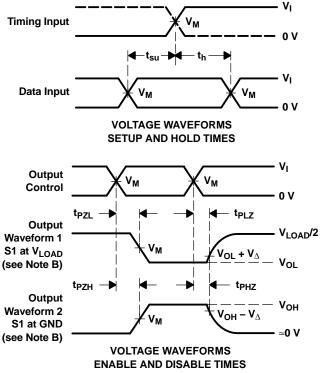
N	INPUTS		N	V	•			
V _{CC}	VI	t _r /t _f	VM	V _{LOAD}	C∟	RL	V_{Δ}	
$\textbf{1.8 V} \pm \textbf{0.15 V}$	V _{CC}	≤2 ns	V _{CC} /2	$2 \times V_{CC}$	30 pF	1 k Ω	0.15 V	
$\textbf{2.5 V} \pm \textbf{0.2 V}$	V _{CC}	≤2 ns	V _{CC} /2	$2 \times V_{CC}$	30 pF	500 Ω	0.15 V	
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V	
3.3 V \pm 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V	

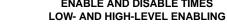


OLTAGE WAVEFORMS PULSE DURATION









- NOTES: A. C_{L} includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω .
 - D. The outputs are measured one at a time, with one transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. t_{PLH} and t_{PHL} are the same as t_{pd} .
 - H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
74LVCH16901DGGRE4	ACTIVE	TSSOP	DGG	64	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74LVCH16901DGGRG4	ACTIVE	TSSOP	DGG	64	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVCH16901DGGR	ACTIVE	TSSOP	DGG	64	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

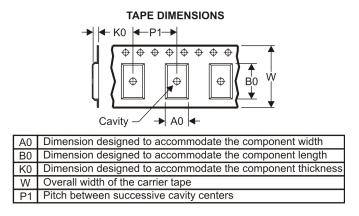
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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions	are nominal
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Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVCH16901DGGR	TSSOP	DGG	64	2000	330.0	24.4	8.4	17.3	1.7	12.0	24.0	Q1



PACKAGE MATERIALS INFORMATION

11-Mar-2008



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVCH16901DGGR	TSSOP	DGG	64	2000	346.0	346.0	41.0

MECHANICAL DATA

MTSS003D - JANUARY 1995 - REVISED JANUARY 1998

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



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